

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/788,836	LEE ET AL.
	Examiner	Art Unit
	Jezia Riley	1637

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
549	223		
435	6		
536	24.33 25.3		
536		6/26/2006	